

<b>Notice of References Cited</b>	Application/Control No. 10/691,249		Applicant(s)/Patent Under Reexamination HSIEH ET AL.	
	Examiner Kevin M. Bernatz		Art Unit 1773	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,908,683	06-1999	Suzuki et al.	428/840.2
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Fox, T., and Flory, P., Letter to Editor in J. Poly. Sci., 14(75), pgs 315 - 319, 1954.
	V	"Chapter 3. Thermal Analysis (Chapter 12 Campbell & White)" available on-line at www.eng.uc.edu/~gbeaucag/Courses/Analysis/Chapter3.pdf.
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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